

October 1987 Revised January 1999

CD4071BC • CD4081BC Quad 2-Input OR Buffered B Series Gate • Quad 2-Input AND Buffered B Series Gate

General Description

The CD4071BC and CD4081BC quad gates are monolithic complementary MOS (CMOS) integrated circuits constructed with N- and P-channel enhancement mode transistors. They have equal source and sink current capabilities and conform to standard B series output drive. The devices also have buffered outputs which improve transfer characteristics by providing very high gain.

All inputs protected against static discharge with diodes to $\rm V_{DD}$ and $\rm V_{SS}.$

Features

- Low power TTL compatibility:
 Fan out of 2 driving 74L or 1 driving 74LS
- 5V-10V-15V parametric ratings
- Symmetrical output characteristics
- Maximum input leakage 1 µA at 15V over full temperature range

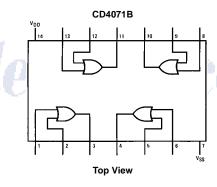
Ordering Code:

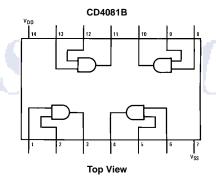
Order Number	Package Number	Package Description
CD4071BCM	M14A	14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-120, 0.150" Narrow
CD4071BCN	N14A	14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide
CD4081BCM	M14A	14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-120, 0.150" Narrow
CD4081BCN	N14A	14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide

Devices are also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Connection Diagrams

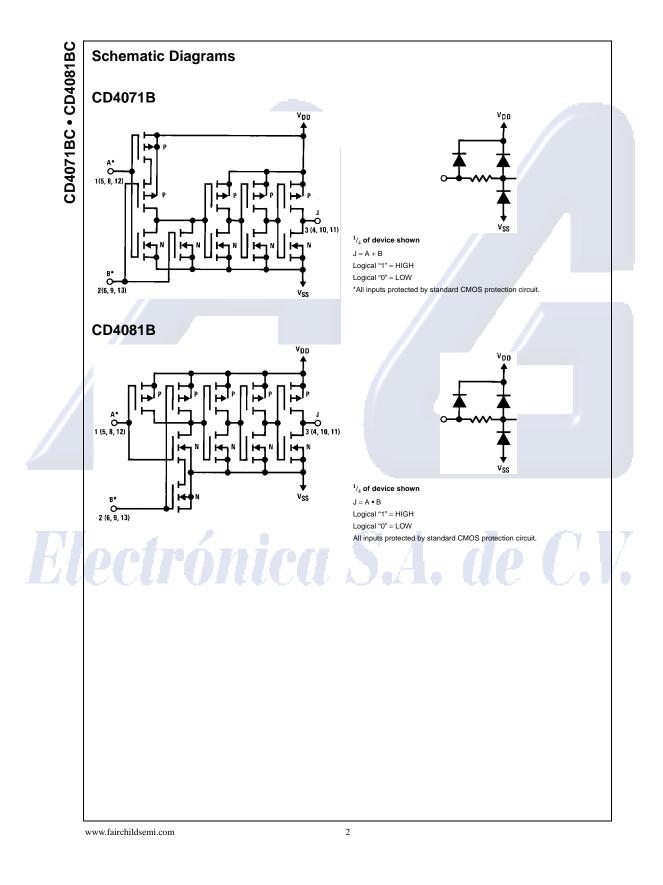
Pin Assignments for DIP and SOIC





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DS005977.prf



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Absolute Maximum Ratings(Note 1)

(Note 2)

Voltage at Any Pin $-0.5 \text{V to V}_{\text{DD}} + 0.5 \text{V}$

Power Dissipation (P_D)

 $\begin{array}{ccc} \text{Dual-In-Line} & 700 \text{ mW} \\ \text{Small Outline} & 500 \text{ mW} \\ \text{V}_{\text{DD}} \text{ Range} & -0.5 \text{ V}_{\text{DC}} \text{ to +18 V}_{\text{DC}} \\ \text{Storage Temperature (T}_{\text{S}}) & -65^{\circ}\text{C to +150}^{\circ}\text{C} \end{array}$

Lead Temperature (T_L)

(Soldering, 10 seconds)

Recommended Operating Conditions

Operating Range (V_{DD}) 3 V_{DC} to 15 V_{DC}

Operating Temperature Range (T_A)

CD4071BC, CD4081BC -40°C to +85°C

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: All voltages measured with respect to V_{SS} unless otherwise specified.

DC Electrical Characteristics (Note 2)

CD4071BC/CD4081BC

Symbol	Parameter	Conditions		-40°C		+25°C			+85°C		Units
Cyllibol	r arameter			Min	Max	Min	Тур	Max	Min	Max	Units
I _{DD}	Quiescent Device	$V_{DD} = 5V$			1		0.004	1	1	7.5	μΑ
	Current	$V_{DD} = 10V$			2		0.005	2		15	μΑ
		$V_{DD} = 15V$			4	-//	0.006	4		30	μΑ
V _{OL}	LOW Level	$V_{DD} = 5V$			0.05	77	0	0.05		0.05	V
	Output Voltage	$V_{DD} = 10V$ $ I_{O} < 1 \mu A$			0.05	7	0	0.05		0.05	V
		V _{DD} = 15V			0.05		0	0.05		0.05	V
V _{OH}	HIGH Level	$V_{DD} = 5V$		4.95	77	4.95	5		4.95		V
- //	Output Voltage	$V_{DD} = 10V$ $ I_O < 1 \mu A$		9.95	1	9.95	10		9.95		V
-//		V _{DD} = 15V		14.95		14.95	15		14.95		V
V _{IL}	LOW Level	$V_{DD} = 5V, V_{O} = 0.5V$			1.5		2	1.5		1.5	٧
1	Input Voltage	$V_{DD} = 10V, V_{O} = 1.0V$			3.0	į.	4	3.0		3.0	V
		$V_{DD} = 15V, V_{O} = 1.5V$			4.0		6	4.0		4.0	V
V _{IH}	HIGH Level	$V_{DD} = 5V, V_{O} = 4.5V$		3.5		3.5	3		3.5		V
	Input Voltage	$V_{DD} = 10V, V_{O} = 9.0V$		7.0		7.0	6		7.0		V
		$V_{DD} = 15V, V_{O} = 13.5V$		11.0		11.0	9		11.0		V
I _{OL}	LOW Level Output	$V_{DD} = 5V, V_{O} = 0.4V$		0.52		0.44	0.88		0.36		mA
	Current	$V_{DD} = 10V, V_{O} = 0.5V$		1.3		1.1	2.25		0.9		mA
	(Note 3)	$V_{DD} = 15V, V_{O} = 1.5V$		3.6		3.0	8.8		2.4		mA
I _{OH}	HIGH Level Output	$V_{DD} = 5V, V_{O} = 4.6V$		-0.52		-0.44	-0.88		-0.36		mA
	Current	$V_{DD} = 10V, V_{O} = 9.5V$		-1.3		-1.1	-2.25		-0.9		mA
	(Note 3)	$V_{DD} = 15V$, $V_{O} = 13.5V$		-3.6		-3.0	-8.8		-2.4		mA
I _{IN}	Input Current	$V_{DD} = 15V, V_{IN} = 0V$			-0.30		-10 ⁻⁵	-0.30		-1.0	μΑ
	TT 11 T 11	$V_{DD} = 15V, V_{IN} = 15V$			0.30	-	10 ⁻⁵	0.30		1.0	μΑ

260°C

Note 3: I_{OH} and I_{OL} are tested one output at a time.

AC Electrical Characteristics (Note 4)

CD4071BC $T_A = 25^{\circ}C$, Input t_f ; $t_f = 20$ ns, $C_L = 50$ pF, $R_L = 200$ k Ω , Typical temperature coefficient is $0.3\%/^{\circ}C$

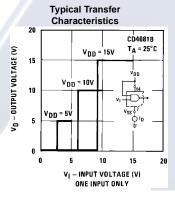
Symbol	Parameter	Conditions	Тур	Max	Units
t _{PHL}	Propagation Delay Time,	$V_{DD} = 5V$	100	250	ns
	HIGH-to-LOW Level	V _{DD} = 10V	40	100	ns
		$V_{DD} = 15V$	30	70	ns
t _{PLH}	Propagation Delay Time,	$V_{DD} = 5V$	90	250	ns
	LOW-to-HIGH Level	$V_{DD} = 10V$	40	100	ns
		$V_{DD} = 15V$	30	70	ns
t _{THL} , t _{TLH}	Transition Time	$V_{DD} = 5V$	90	200	ns
		$V_{DD} = 10V$	50	100	ns
		$V_{DD} = 15V$	40	80	ns
C _{IN}	Average Input Capacitance	Any Input	5	7.5	pF
C _{PD}	Power Dissipation Capacity	Any Gate	18		pF

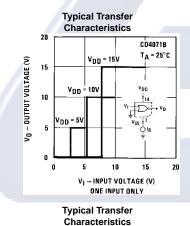
Note 4: AC Parameters are guaranteed by DC correlated testing.

CD4071BC • CD4081BC

AC Electrical Characteristics (Note 5) CD4081BC T_A = 25°C, Input t_r; t_f = 20 ns, C_L = 50 pF, R_L = 200 k Ω , Typical temperature coefficient is 0.3%/°C Max Units Propagation Delay Time, $I_{DD} = 5V$ 100 250 ns t_{PHL} HIGH-to-LOW Level $V_{DD} = 10V$ 40 100 ns $V_{DD} = 15V$ 30 70 ns $V_{DD} = 5V$ Propagation Delay Time, t_{PLH} ns LOW-to-HIGH Level $V_{DD} = 10V$ 50 100 $V_{DD} = 15V$ 35 70 ns $V_{DD} = 5V$ 90 200 Transition Time $t_{THL},\,t_{TLH}$ ns $V_{DD} = 10V$ 50 100 ns $V_{DD} = 15V$ 40 80 Average Input Capacitance 5 7.5 C_{IN} Any Input pF Power Dissipation Capacity Any Gate 18 рF Note 5: AC Parameters are guaranteed by DC correlated testing.

Typical Performance Characteristics

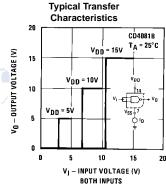


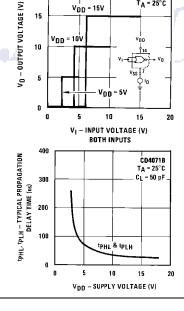


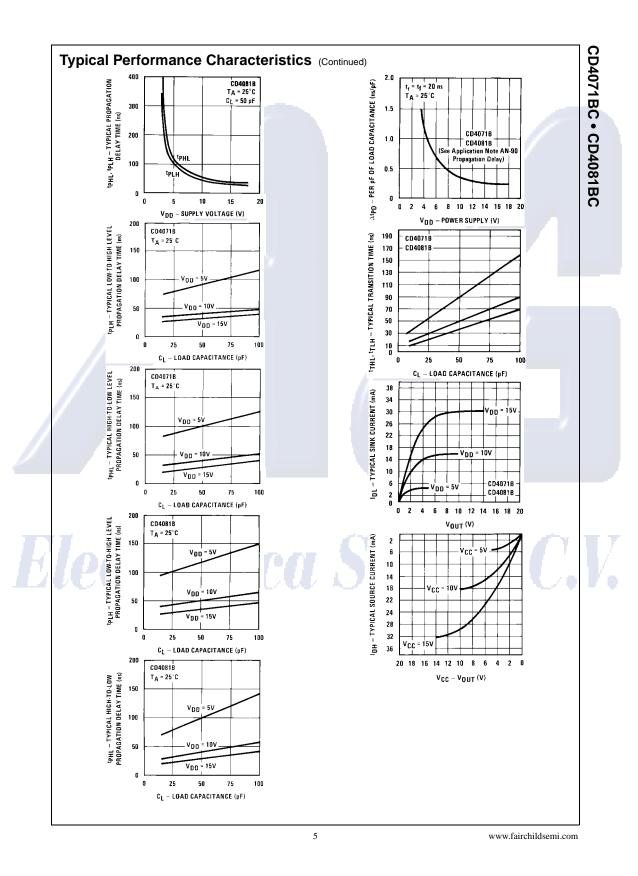
V_{DD} = 15V

CD4071B

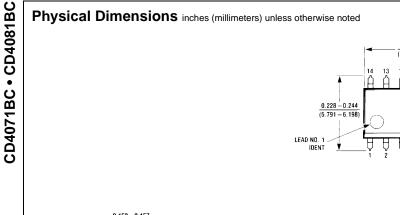
TA = 25°C

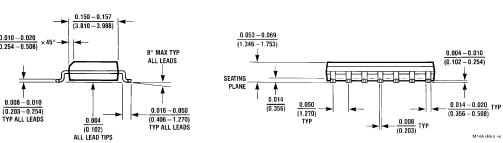






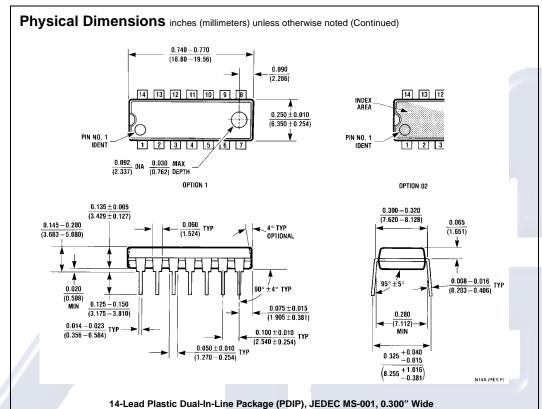
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14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-120, 0.150" Narrow Package Number M14A

Electrónica S.A. de C.V.



Electrónica S.A. de C.

Package Number N14A

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